

DuraMAT 2018 Fall Workshop

Location: Talks (Kavli Auditorium) and posters (SUSB:53) Talk Length: 5-7 minutes, with 3 minutes after for online reviews Please hold questions until discussion panels at the end of each session Wifi: SLAC Visitor, connect and complete online form

Tuesday Aug.28th

12:00 – 1:30 Registration, Posters up – (cafeteria available for lunch)

Session I – Welcomes and Keynote 1

Session Chair – Nancy Haegel, NREL

| 1:30 - 1:45 | Welcome, Workshop Goals, Review Logistics – Teresa Barnes, NREL |
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| 1:45 - 2:00 | Comments from DOE – Dana Olson, DOE |
| 2:00 - 2:30 | DuraMAT Consortium Update |
| | Teresa Barnes, NREL/Margaret Gordon, SNL |
| 2:30 - 3:00 | What's next for PV accelerated testing? |
| | Gabriela Bunea, SunPower |
| | |

3:00 – 3:30 Break w/Posters

Session II – DuraMAT capability Presentations

Session Chair - Margaret Gordon, SNL

| 3:30 - 3:40 | The DuraMAT DataHub; Year 1 |
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| | Robert White, NREL- Feedback |

- 3:40 3:50 Capability 1 Data Analytics Anubhav Jain, LBL– <u>Feedback</u>
- 3:50 4:00 Capability 2 Predictive Simulation: Progress and Updates James Hartley, SNL– <u>Feedback</u>
- 4:00 4:10 Capability 3 Materials Forensics for Understanding PV Module Material Durability, Stephanie Moffit, SLAC– <u>Feedback</u>
- 4:10-4:20 Capability 4 Combined-Accelerated Stress Testing for Advanced Reliability Assessment of Photovoltaic Modules Michael Owen-Bellini, NREL–<u>Feedback</u>
- 4:20 4:30 Capability 5 Field Deployment for Reliability Bruce King, SNL– <u>Feedback</u>
- 4:30 4:40 Capability 6 DuraMAT's Value Proposition to PV Project Economics by Targeting Improved Energy Yield and Lower Operations and Maintenance Expenses, Mike Woodhouse, NREL– <u>Feedback</u>
- 4:40 5:00 Discussion panel with Capability leads Panel Moderator: Margaret Gordon, SNL











5:00 – 6:30 DuraMAT poster presentations and welcome reception (capability leads at posters)

Wednesday Aug. 29th

Breakfast 7:30 – 9:00

Session III – Keynote Session – Reliability of Glass/Glass Compared to Glass/Backsheet – What do we know and What do we need to know?

Session Chair - Teresa Barnes, NREL

| 9:00 - 9:20 | Keynote: Basics of Glass/Glass Reliability – Historical Data, Literature |
|--------------|---|
| | Reports, and What we Know Now, Josh Stein, SNL |
| 9:20 - 9:40 | Keynote: Glass/Glass vs. Glass Module Differences and Field Performance - |
| | What can we learn from limited field data? Dirk Jordan, NREL |
| 9:40 - 10:00 | Discussion of research needs and data gaps for glass/glass modules |
| | Moderators: Dirk Jordan, NREL & Josh Stein, SNL |

10:00 – 10:30 Break with posters (university and industry at posters)

Session IV – University and Industry projects

Session Chair: Mark Hartney, SLAC

| 10:30 - 10:40 | Novel Electrically Conductive Adhesive Materials with Multiple Fillers |
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| | Yu Zhu, University of Akron- Feedback |

- 10:40 10:50 Characterizing Adhesives and Edge Seals for Roll to Roll Photovoltaics Packaging, Samuel Graham, Georgia Tech–<u>Feedback</u>
- 10:50 11:00 Demonstrating New Concepts for Reliable Low-Cost Module Encapsulation and Barrier Technologies

Daisy Yuen, Nick Rolston, Patrick Thornton, Stanford-Feedback

- 11:00 11:10 Hydrophobic-Hydrophilic Coatings for PV Solar Cover Glass Alan Lyons, CUNY– <u>Feedback</u>
- 11:10 11:20 Low-Cost, Advanced Metallization to Mitigate Cell-Crack-Induced Degradation Sang Han, Osazda Energy LLC– Feedback
- 11:20 11:30 Advanced Multifunctional Coatings for PV Glass to Reduce Soiling Losses Drew Fleming, WattGlass – Feedback
- 11:30 11:40 25 Year Low Cost Flexible Frontsheet David Okawa, SunPower– <u>Feedback</u>
- 11:40 12:00 Panel Discussion with project leads Panel Moderator: Mark Hartney, SLAC











12:00 – 1:30 Luncheon / Posters (university and industry at posters 1-1:30)

Session V - University projects and SPARKS

Session Chair - Laura Schelhas, SLAC

| 1:30 - 1:40 | Direct Imaging of Stress in Crystalline Silicon Modules |
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| | Mariana Bertoni, Arizona State University/QESST– Feedback |
| 1:40 - 1:50 | Failure Mechanisms in ECA Interconnects: X-Ray Tomography |
| | Kathryn Fisher, Arizona State University/QESST-Feedback |
| 1:50 - 2:00 | Reliability of Modules Using High Efficiency Solar Cells with Copper Plated |
| | Contacts, Stuart Bowden, Arizona State University/QESST-Feedback |
| 2:00 - 2:10 | Discovering New materials for PV Encapsulation |
| | Tushar Shimpi, Colorado State University/NGPV– Feedback |
| 2:20 - 2:30 | A Novel Method to Evaluate the Crack Propensity of PV Backsheets |
| | Michael Kempe, NREL– <u>Feedback</u> |
| 2:30 - 2:40 | Cohesive Zone Model to Simulate PV Encapsulant Delamination |
| | Nick Bosco, NREL– <u>Feedback</u> |
| 2:40 - 3:00 | Panel Discussion with project leads |
| | Panel Moderator: Laura Schelhas and Don Jenket |

Session VI –New Capability Development Projects

Session Chair – Stephanie Moffitt, SLAC

- 3:00 3:10 New capability Presentations (2 slides each, 2-3 min/ person)
 - A Unified Constitutive Model for the Degradation of Electrically Conductive Adhesives Nick Bosco, NREL
 - Correlation of Advanced Accelerated Stress Testing Comparison of Backsheet Properties After Accelerated Testing and Field Deployment Michael Owen-Bellini, NREL
 - Module Level Solutions for Degradation by Ionization Damage Peter Hacke, NREL
 - DuraMAT Fielded Module Study Comparison of Module Materials Properties Before and After Deployment Bruce King, SNL

Full DuraMAT Consortium Review– <u>Feedback</u> (Everyone is welcome to provide feedback)

- 3:10 4:00 Break with posters (sparks and new capabilities at posters)
- 4:00 5:30 IAB closed session IAB board members and DuraMAT leadership











Thursday Aug. 30th

DuraMAT team – DuraMAT Leadership Team and Capability Leaders Required, DECS invited.

Breakfast 7:30 - 9:00

8:30 – 12:00 DuraMAT Core Team Work Session Leadership Team and Capability Leaders required to attend Industry Board Members welcome

Lunch on your own – SLAC Cafeteria available









